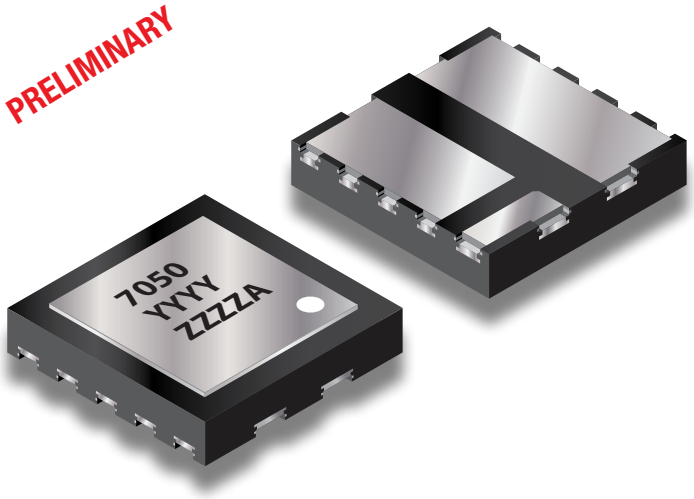
Features

- 3.3 x 3.3 mm QFN package
- Very low on-resistance $R_{DS(on)}$
- Logic Level
- Light Weight
- Ultra-low Q_G
- PQFN Package with Backside Thermal Pad

Applications

- High DC-DC Conversion
- Synchronous Rectifiers
- Servers
- Artificial Intelligence



EPC7050PC

eGaN® FET in a Plastic Surface Mount 15 V, 101 A, 0.28 mΩ

Thermal Characteristics

Symbol	Parameter-Conditions	Value	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Case TOP)	0.4	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board (Case BOTTOM)	0.9	

Description

EPC's eGaN® power switching HEMTs have been specifically designed for critical applications in DC-DC conversion. These devices have exceptionally high electron mobility and a low temperature coefficient resulting in very low $R_{DS(on)}$ values. The lateral structure of the die provides for very low gate charge (Q_G) and extremely fast switching times. These features enable faster power supply switching frequencies resulting in higher power densities, higher efficiencies and more compact packaging.

Maximum Rating

Symbol	Parameter-Conditions	Value	Units
V_{DS}	Drain-to-Source Voltage (Note 1)	15	V
$V_{DS(tr)}$	Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	18	
I_D	Continuous Drain Current at V_{GS} = 5 V	101	A
	Pulsed (25°C, T_{PULSE} = 300 µs)	783	
V_{GS}	Gate-to-Source Voltage	+6 / -4	V
T_J	Operating Temperature	–40 to 150	°C
T_{STG}	Storage Temperature	–40 to 150	

(1) Pulsed repetitively, duty cycle factor (DC_{Factor}) ≤ 1%;
See Figure 13 and **Reliability Report Phase 16**, Section 3.2.6

Static Characteristics# *(T_J = 25°C unless otherwise noted)*

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units
Drain to Source Voltage	B_{VDSS}	V_{GS} = 0 V, I_D = TBD	15			V
Drain to Source Leakage	I_{DSS}	V_{GS} = 0 V, V_{DS} = 15 V		0.17		mA
		V_{GS} = 0 V, V_{DS} = 15 V, T_J = 125°C				
Gate to Source Forward Leakage	I_{GSS}	V_{GS} = 5 V		0.04		
Gate to Source Forward Leakage		V_{GS} = 5 V, T_J = 125°C				
Gate to Source Reverse Leakage		V_{GS} = -2 V		0.3		
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS} , I_D = 25 mA	0.8	1.1	2.5	V
Drain to Source On Resistance (Note 3)	$R_{DS(on)}$	V_{GS} = 5 V, I_D = 30 A		0.28		mΩ
Source to Drain Forward Voltage	V_{SD}	I_S = 0.5 A, V_{GS} = 0 V		1.4		V

Dynamic Characteristics# *(T_J = 25°C unless otherwise noted)*

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units
Input Capacitance	C_{ISS}	V_{DS} = 8 V, V_{GS} = 0 V		4390		pF
Reverse Transfer Capacitance	C_{RSS}			132		
Output Capacitance	C_{OSS}			1930		
Effective Output Capacitance, Energy Related (Note 4)	$C_{OSS(ER)}$	V_{DS} = 0 to 8 V, V_{GS} = 0 V		2366		
Effective Output Capacitance, Time Related (Note 5)	$C_{OSS(TR)}$			2537		
Total Gate Charge (Note 6)	Q_G	V_{DS} = 8 V, V_{GS} = 5 V, I_D = 30 A		31		nC
Total Gate Charge Synchronous (Note 6)	$Q_{G\ SYNC}$	V_{DS} = 0 V, V_{GS} = 5 V, I_D = 0 A		29		
Gate to Drain Charge (Note 7)	Q_{GD}	V_{DS} = 8 V, I_D = 30 A		1.5		
Gate Charge at Threshold	$Q_{G(TH)}$			8		
Output Charge (Note 6)	Q_{OSS}	V_{DS} = 8 V, V_{GS} = 0 V		29		
Source to Drain Recovery Charge (Note 6)	Q_{RR}			0		

All measurements were done with substrate connected to source.

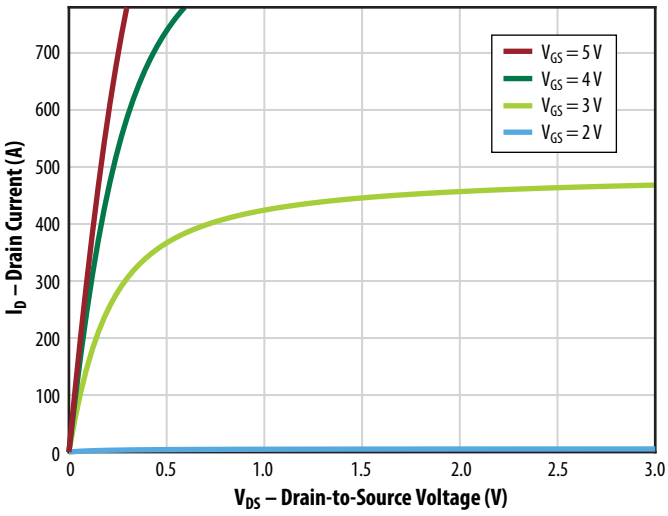


Figure 1: Typical Output Characteristics at 25°C

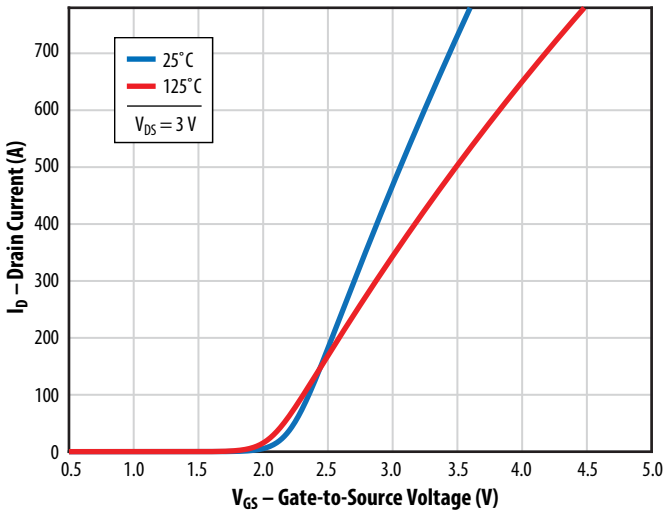


Figure 2: Typical Transfer Characteristics

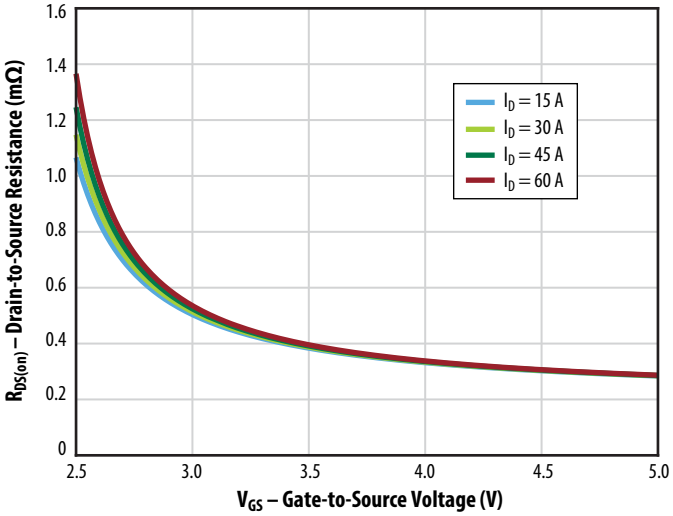


Figure 3: Typical $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

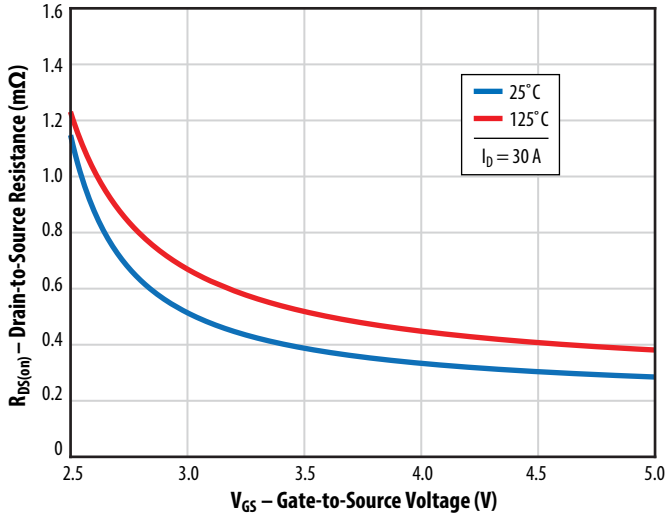


Figure 4: Typical $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

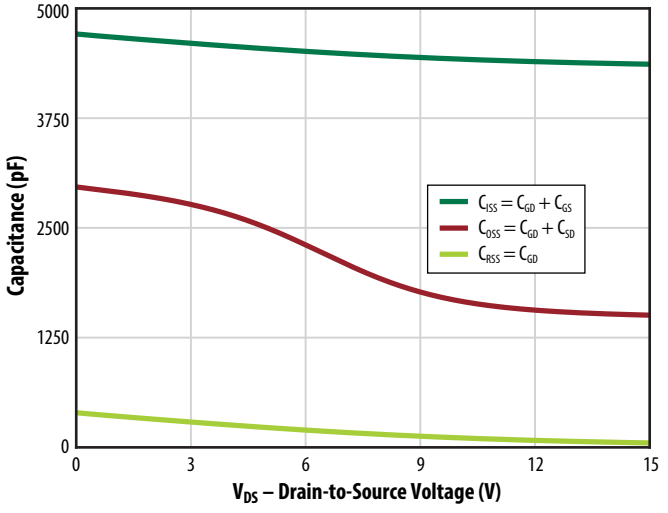


Figure 5a: Typical Capacitance (Linear Scale)

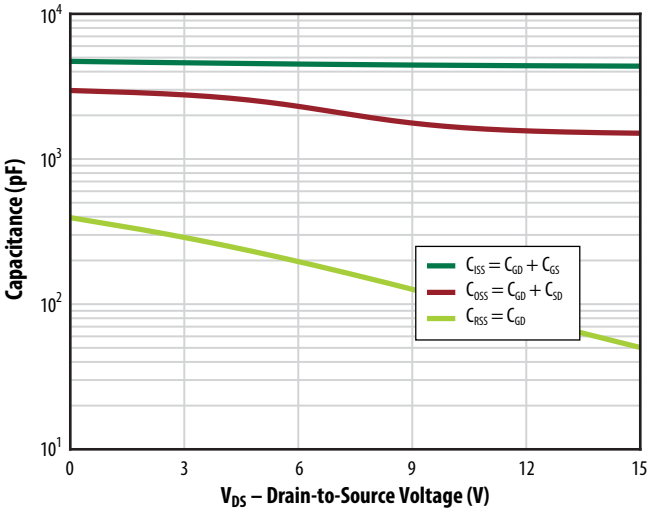


Figure 5b: Typical Capacitance (Log Scale)

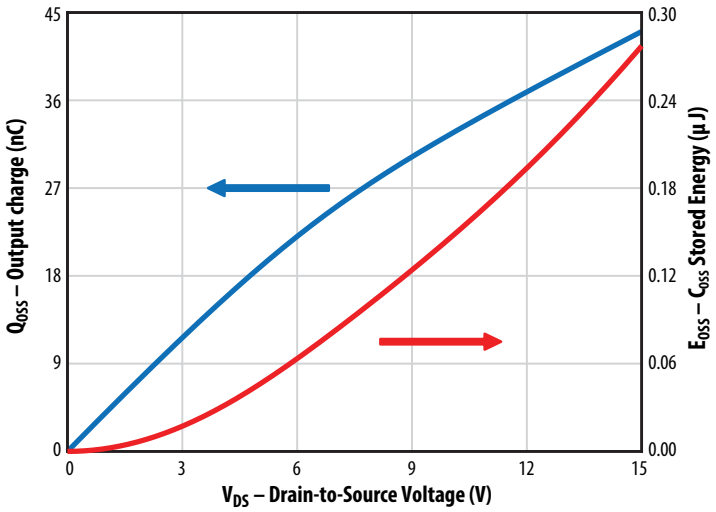


Figure 6: Typical Output Charge and C_{OSS} Stored Energy

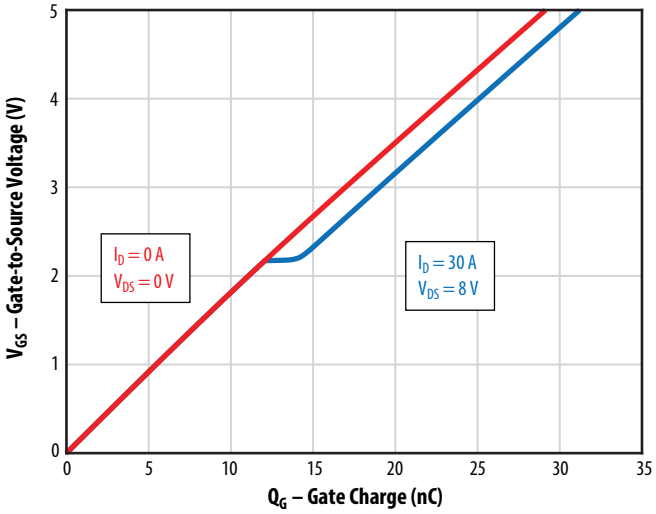
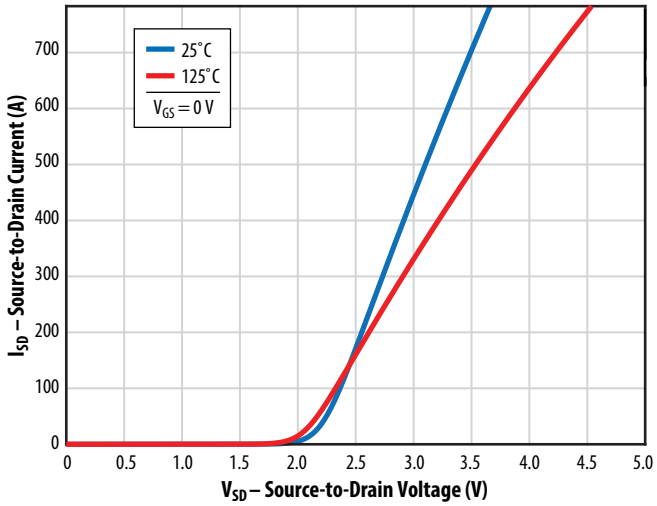


Figure 7: Typical Gate Charge



Negative gate drive voltage increases the reverse drain-source voltage. EPC recommends 0 V for OFF

Figure 8: Typical Reverse Drain-Source Characteristics

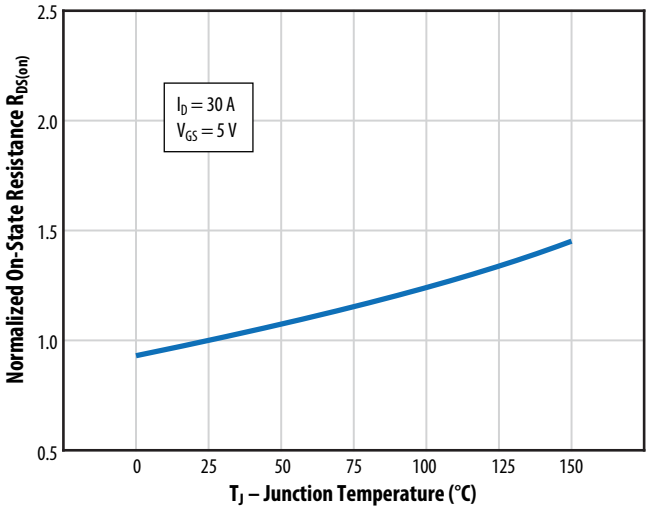


Figure 9: Typical Normalized On-State Resistance vs. Temperature

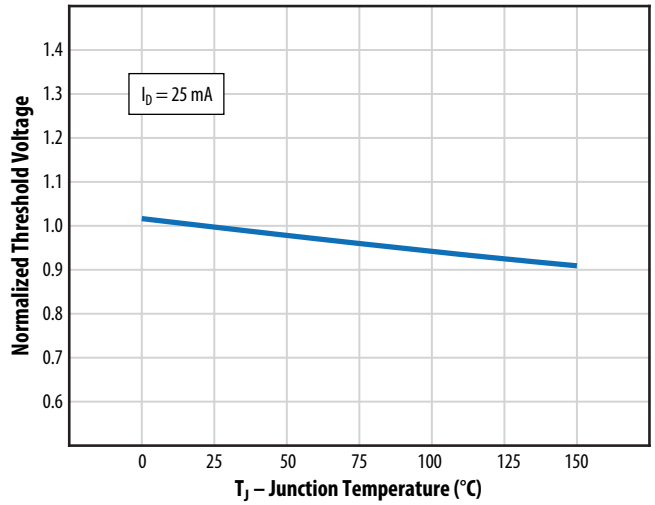
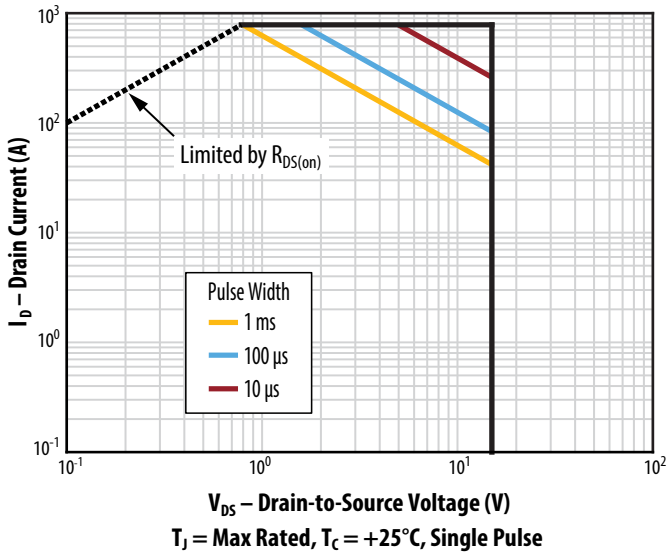


Figure 10: Typical Normalized Threshold Voltage vs. Temp.



T_J = Max Rated, T_C = +25°C, Single Pulse

Figure 11: Safe Operating Area

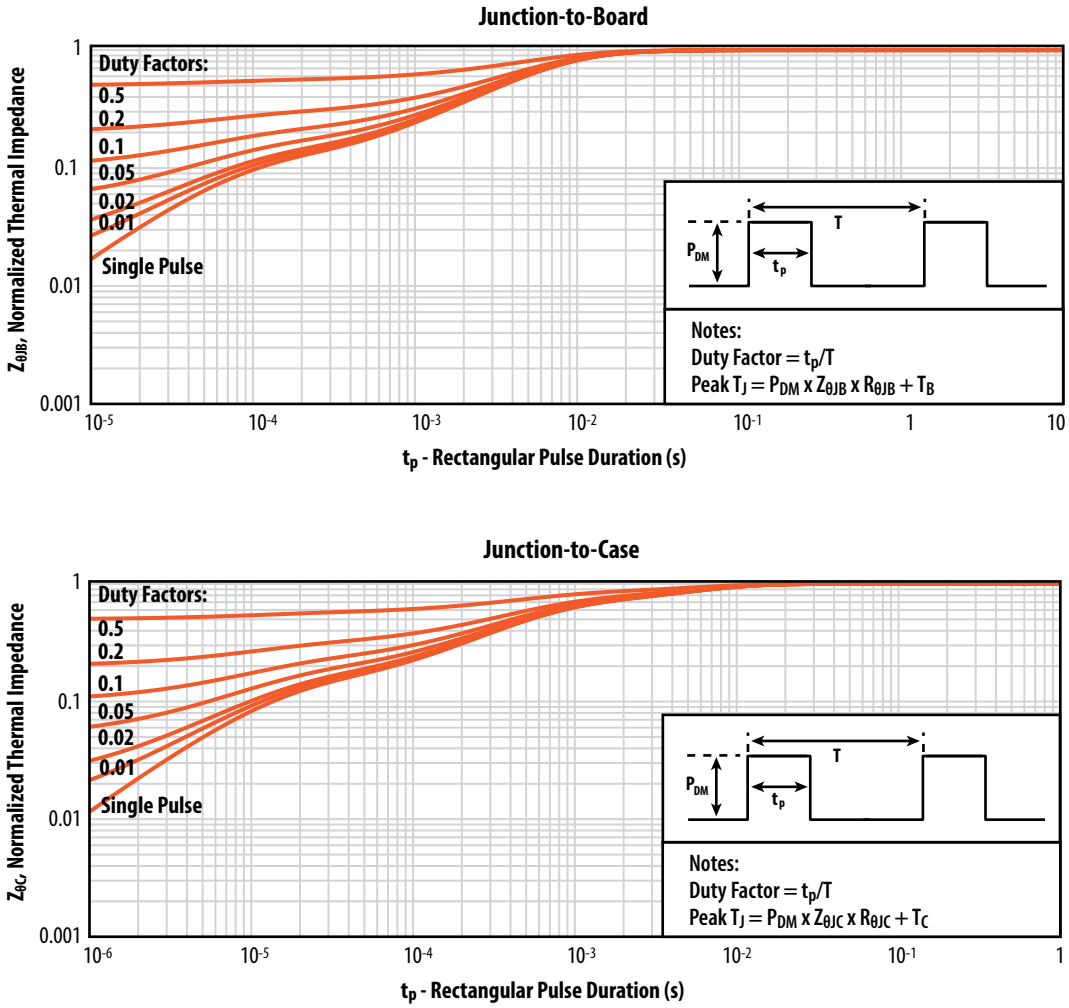


Figure 12: Typical Transient Thermal Response Curves

Typical Thermal Concept

The EPC7050PC can take advantage of dual sided cooling to maximize its heat dissipation capabilities in high power density designs. ***Note that the top of EPC FETs are connected to source potential, so for half-bridge topologies the Thermal Interface Material (TIM) needs to provide electrical isolation to the heatsink.***

Recommended best practice thermal solutions are covered in detail in **How2AppNote012 - How to Get More Power Out of an eGaN Converter.pdf**.

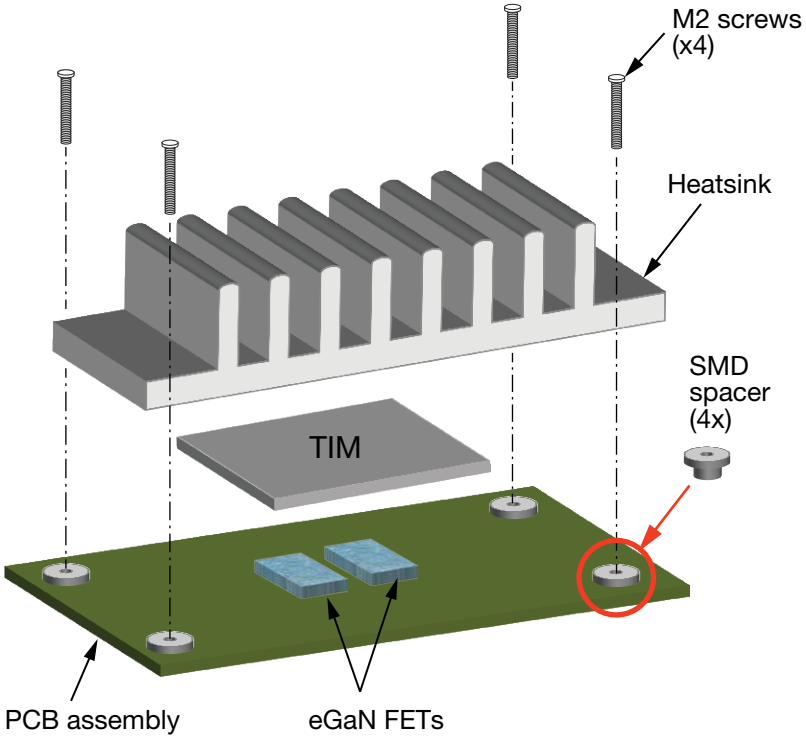


Figure 18: Exploded view of heatsink assembly using screws

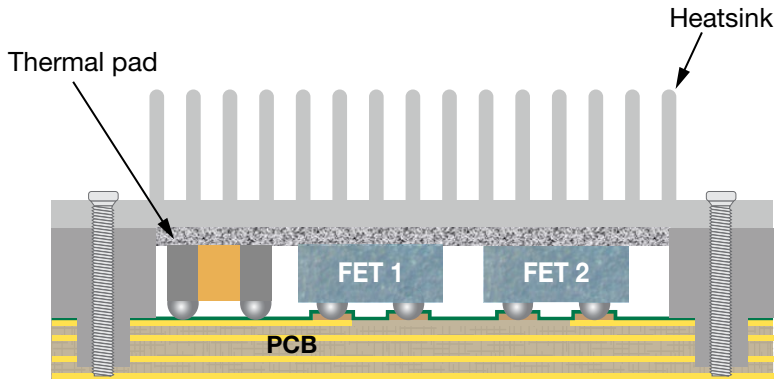


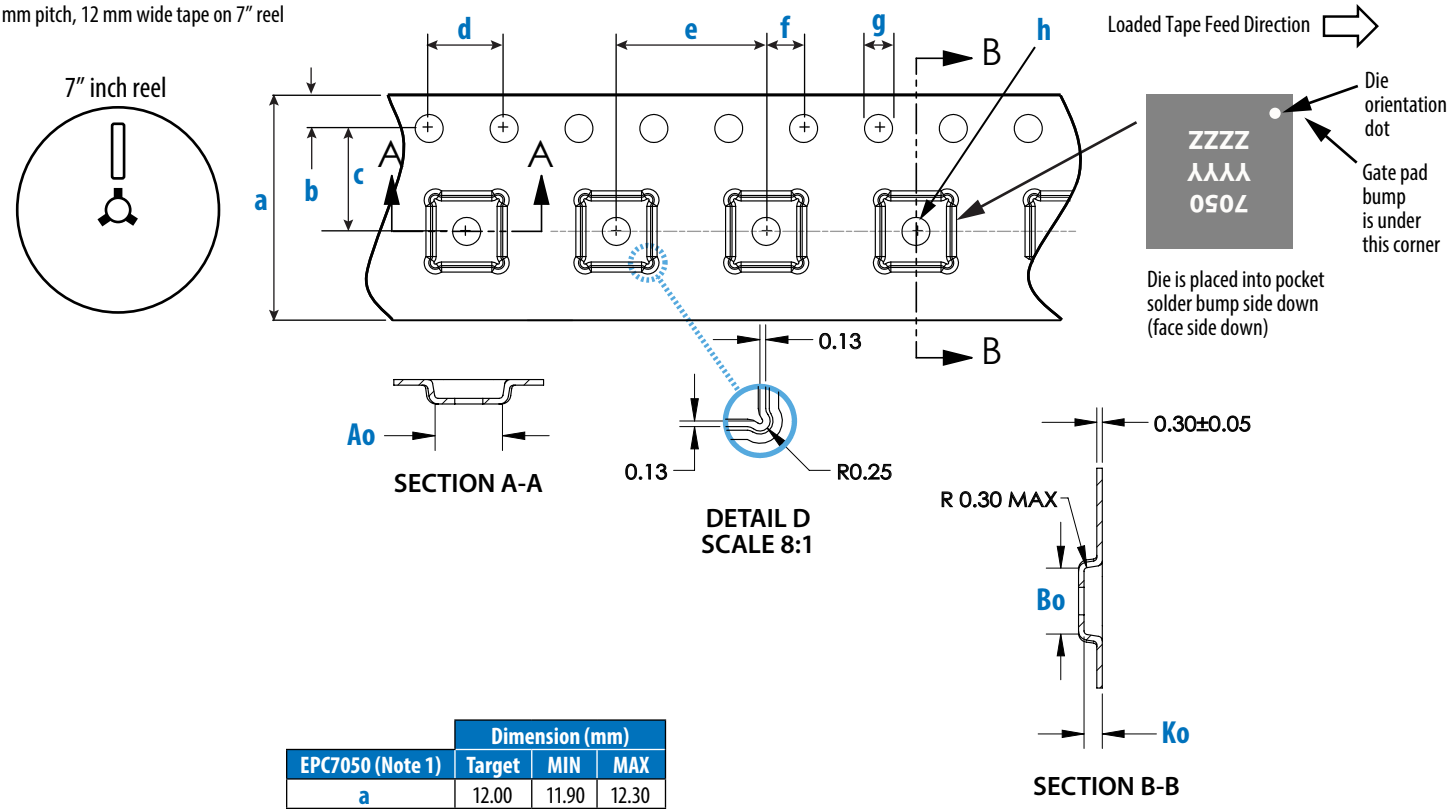
Figure 19: A cross-section image of dual sided thermal solution

Note: Connecting the heatsink to ground is recommended and can significantly improve radiated EMI

The thermal design can be optimized by using the **GaN FET Thermal Calculator** on EPC's website.

TAPE AND REEL CONFIGURATION

8 mm pitch, 12 mm wide tape on 7″ reel

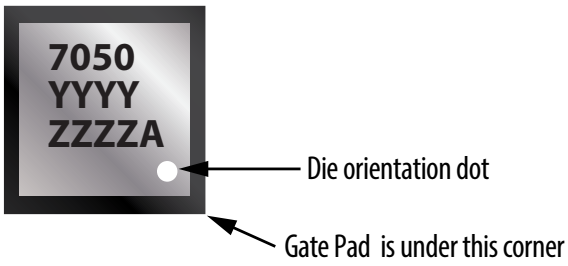


	Dimension (mm)		
EPC7050 (Note 1)	Target	MIN	MAX
a	12.00	11.90	12.30
b	1.75	1.65	1.85
c (Note 2)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	8.00	7.90	8.10
f (Note 2)	2.00	1.95	2.05
g	1.50	1.50	1.60
h	1.50	1.50	1.60
Ao	3.6	3.4	3.5
Bo	3.6	3.4	3.5
Ko	1.0	0.9	1.1

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.

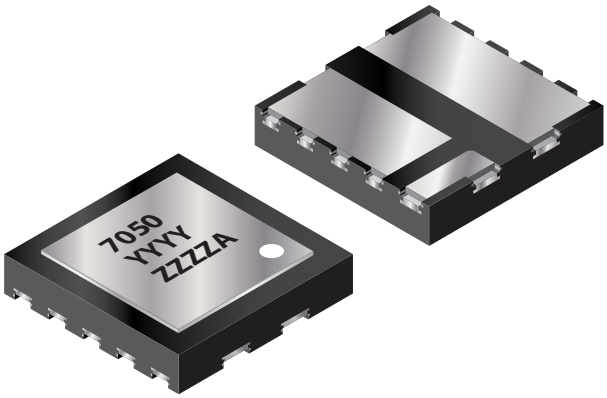
Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

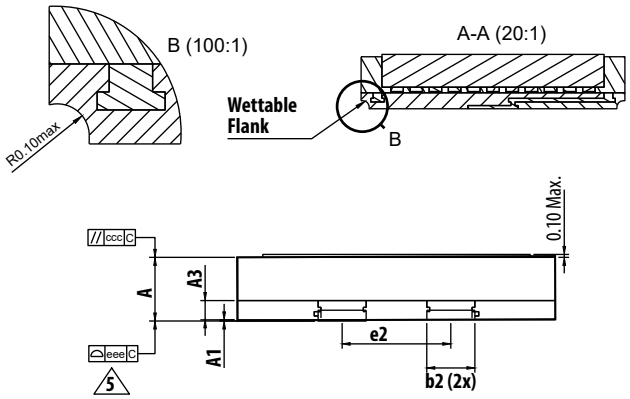
Part Marking



Part Number	Laser Markings		
	Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC7050PC	7050	YYYY	ZZZZA

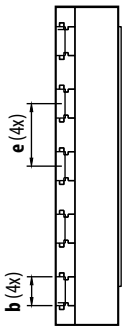
PACKAGE OUTLINE AND DIMENSIONS



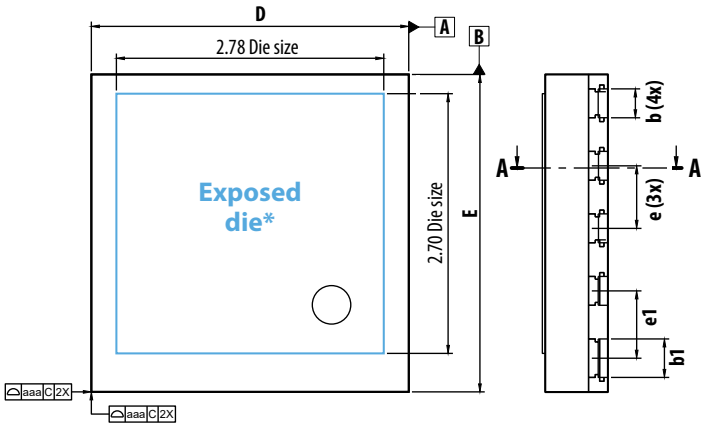


Front View

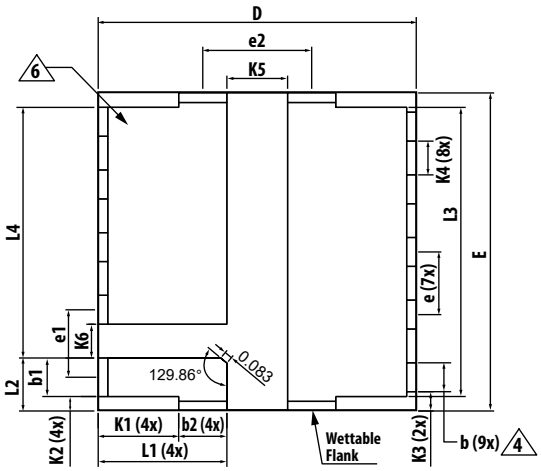
Side View



Top View



Bottom View



*The exposed die is the silicon substrate that is internally connected to the source.
It is not recommended to use it as an electrical connection

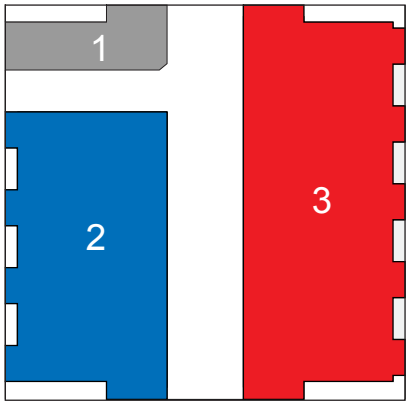
SYMBOL	Dimension (mm)			
	MIN	Nominal	MAX	Note
A	0.60	0.65	0.70	
A1	0.00	0.02	0.05	
A3			0.25	
b	0.25	0.30	0.35	4
b1	0.35	0.40	0.45	4
b2	0.45	0.50	0.55	4
D	3.20	3.30	3.40	
E	3.20	3.30	3.40	
e		0.65		BSC
e1		0.70		BSC
e2		1.13		BSC
L1	1.235	1.335	1.435	
L2	0.45	0.55	0.65	
L3	2.90	3.00	3.10	
L4	2.15	2.25	2.35	

SYMBOL	Dimension (mm)			
	MIN	Nominal	MAX	Note
K1		0.835		REF
K2		0.15		REF
K3		0.20		REF
K4		0.35		REF
K5		0.63		REF
K6		0.35		REF
aaa		0.05		
ccc		0.10		
eee		0.08		
N		3		3

Notes:

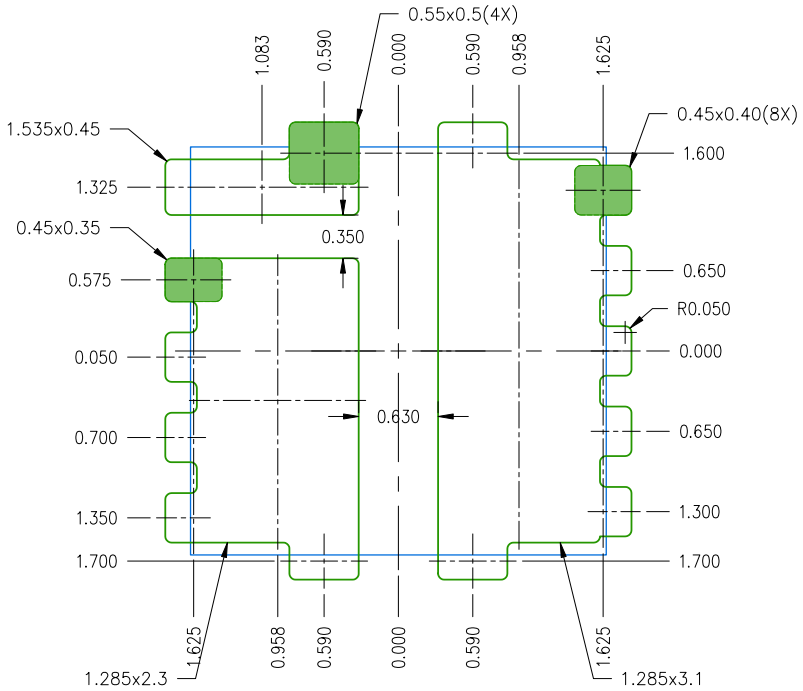
1. Dimensioning and tolerancing conform to ASME Y14.5-2009
2. All dimensions are in millimeters
3. **N** is the total number of terminals
4. Dimension **b** applies to the metallized terminal. If the terminal has a radius on the other end of it, dimension **b** should not be measured in that radius area.
5. Coplanarity applies to the terminals and all the other bottom surface metallization.
6. Lead plating is NiPdAu (1.5/0.01/0.005 µm min). Au as the finish.

TRANSPARENT VIEW



PIN	DESCRIPTION
1	Gate
2	Source
3	Drain

RECOMMENDED LAND PATTERN
(units in mm)

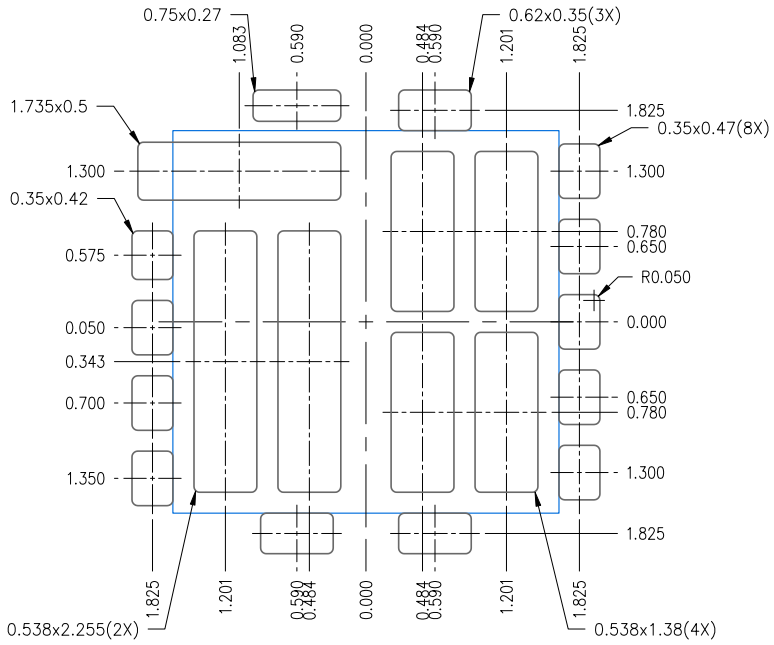


Legend:
Part Outline
Mask Opening

Radius = 0.05

Land pattern is solder mask defined

RECOMMENDED STENCIL DRAWING
(units in mm)



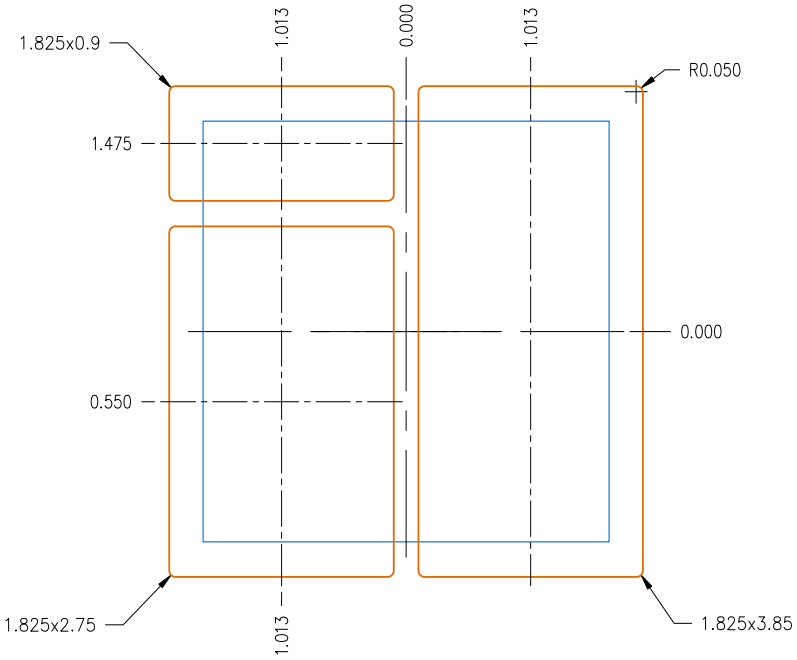
Legend:
Part Outline
Stencil Opening

The recommended stencil should be 4mils (100 µm) thick, must be laser cut, and have openings per drawing.

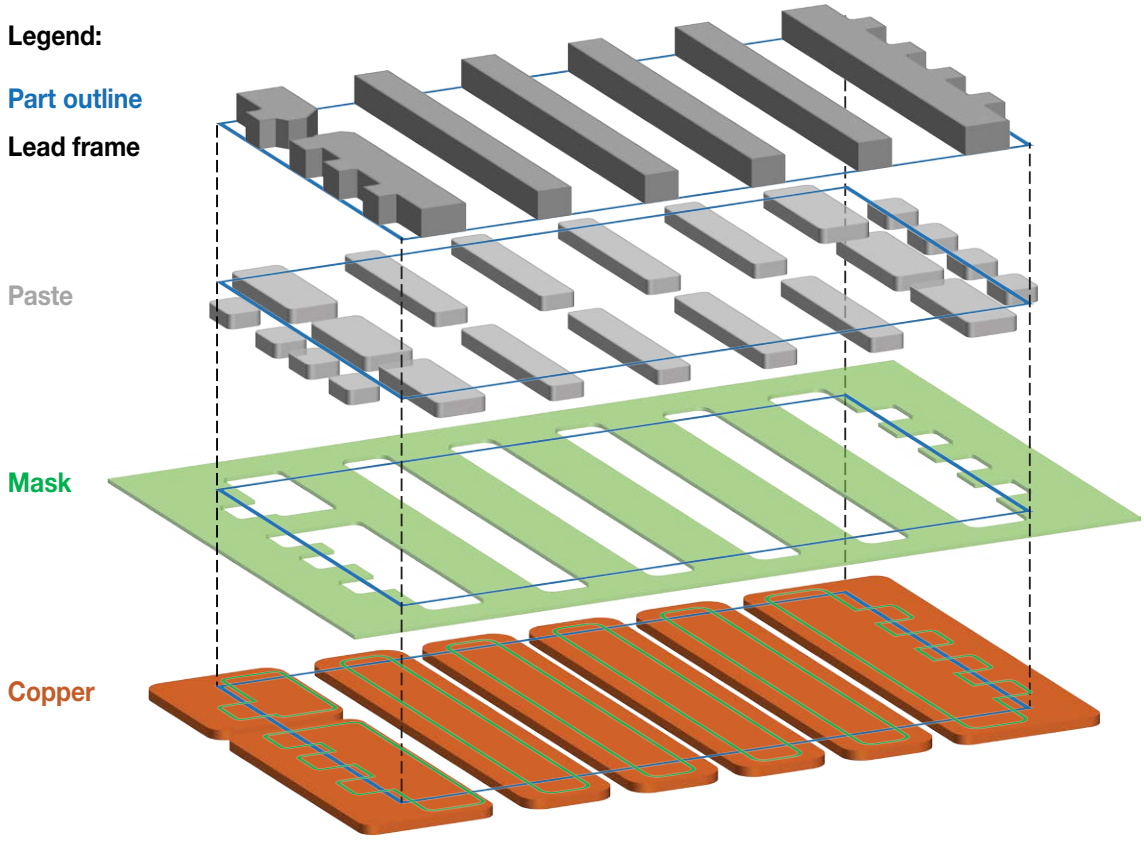
Intended for use with SAC305 Type 4 solder, reference 88.5% metal content.

RECOMMENDED COPPER DRAWING

(units in mm)



3D Composite



Note 1. Never exceed the absolute maximum V_{DS} of the device otherwise permanent damage/destruction may result.

Note 2. Never exceed the absolute maximum V_{GS} of the device otherwise permanent damage/destruction may result. We recommend a V_{GS} of 5 V for optimum operation across life and radiation.

Note 3. Measured using four wire (Kelvin) sensing and pulse measurement techniques. Measurement pulse width is 80 µs and duty cycle is 1%, maximum.

Note 4. $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Note 5. $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Note 6. Guaranteed by design/device construction. Not Tested.

Note 7. The gate charge parameters are measured based on the MIL-STD-750.3471 Condition B. A high speed constant gate current (I_{const}) is provided to the Gate of the DUT during the time that the ground switch (G_S) is OFF (t_{off}). The DUT is switched ON and OFF using ground-sensed switch G_S. The gate current is adjusted to yield the desired charge per unit time (I_{const} · time per division) on the measuring oscilloscope. The G_S pulse drive ON time (t_{on})is adjusted for the desired observability of the gate-source voltage (V_{GS}) waveform. The maximum duty cycle of the ground switch (t_{off} /t_{on}) should be set to 1% maximum. Please note that all gate-related signals are referenced to the “Source Sense” pin on the package. At all times during the measurement, the maximum gate-source voltage is clamped to 5 V_{DC}.

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Information subject to change without notice.

Change Log

Status	Version	Date	Remark
1.0	Preliminary datasheet	24 April 2026	Production Release